

**Notice of References Cited**

Application/Control No.

10/697,779

Applicant(s)/Patent Under

Reexamination

HOFFMAN ET AL.

Examiner

MOHAMED WASEL

Art Unit

2454

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-2002/0038419 A1	03-2002	Garrett et al.	713/154
*	B US-2003/0117954 A1	06-2003	De Neve et al.	370/230
*	C US-2003/0217129 A1	11-2003	Knittel et al.	709/223
*	D US-2005/0129026 A1	06-2005	Chang et al.	370/395.2
*	E US-2005/0232183 A1	10-2005	Sartori et al.	370/319
*	F US-7,069,344 B2	06-2006	Carolan et al.	709/250
*	G US-2007/0215684 A1	09-2007	Jones, Adrian	235/375
*	H US-2008/0037578 A1	02-2008	CARLSON et al.	370/463
*	I US-2008/0141355 A1	06-2008	Chevalier et al.	726/7
*	J US-2008/0222291 A1	09-2008	Weller et al.	709/226
*	K US-2009/0019163 A1	01-2009	Pecus, Vivian	709/226
*	L US-2009/0070454 A1	03-2009	McKinnon et al.	709/224
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	
V	
W	
X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.